## Notice of References Cited Application/Control No. 10/023,344 Examiner Lao Y Lun Applicant(s)/Patent Under Reexamination MIWA ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,027,456	06-2000	Karube et al	345/98
	В	US-6,377,235	04-2002	Murade et al	345/100
	С	US-6,392,628	05-2002	Yamazaki et al	345/98
	D	US-6,507.332	01-2003	Kuwabara et al	345/103
	E	US-6,611,261	08/2003	Zhang et al	345/204
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document,Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	w						
	х						

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